

T-45-07



CD4008B Types

CMOS 4-Bit Full Adder

With Parallel Carry Out

High-Voltage Types (20-Volt Rating)

■ CD4008B types consist of four full adder stages with fast look ahead carry provision from stage to stage. Circuitry is included to provide a fast "parallel-carry-out" but to permit high-speed operation in arithmetic sections using several CD4008B's.

CD4008B inputs include the four sets of bits to be added, A₁ to A₄ and B₁ to B₄, in addition to the "Carry In" bit from a previous section. CD4008B outputs include the four sum bits, S₁ to S₄. In addition to the high speed "parallel-carry-out" which may be utilized at a succeeding CD4008B section.

The CD4008B types are supplied in 16-lead hermetic dual-in-line ceramic packages (D and F suffixes), 16-lead dual-in-line plastic packages (E suffix), and in chip form (H suffix).

Features:

- 4 sum outputs plus parallel look-ahead carry-output
- High-speed operation — sum in-to-sum out, 160 ns typ; carry in-to-carry out, 50 ns typ. at V_{DD} = 10 V, C_L = 50 pF
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μ A at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (over full package temperature range): 1 V at V_{DD} = 5 V
2 V at V_{DD} = 10 V
2.5 V at V_{DD} = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

Applications:

- Binary addition/arithmetic units

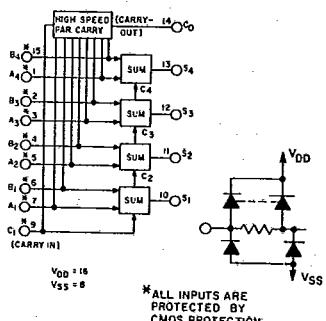
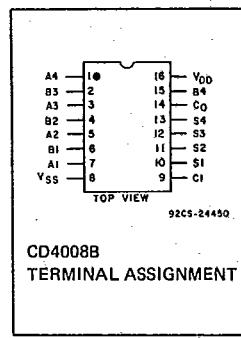


Fig.1 — CD4008B logic diagram.

TRUTH TABLE

A _i	B _i	C _i	C ₀	SUM
0	0	0	0	0
1	0	0	0	1
0	1	0	0	1
1	1	0	1	0
0	0	1	0	1
1	0	1	1	0
0	1	1	1	0
1	1	1	1	1

STATIC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)						UNITS	
	V _O (V)	V _{IN} (V)	V _{DD} (V)	-55	-40	+85	+125	Min.	Typ.	Max.	
Quiescent Device Current, I _{DD} Max.	—	0.5	5	5	5	150	150	—	0.04	5	μ A
	—	0.10	10	10	10	300	300	—	0.04	10	
	—	0.15	15	20	20	600	600	—	0.04	20	
	—	0.20	20	100	100	3000	3000	—	0.08	100	
Output Low (Sink) Current I _{OL} Min.	0.4	0.5	5	0.64	0.61	0.42	0.36	0.51	1	—	mA
	0.5	0.10	10	1.6	1.5	1.1	0.9	1.3	2.6	—	
	1.5	0.15	15	4.2	4	2.8	2.4	3.4	6.8	—	
Output High (Source) Current, I _{OH} Min.	4.6	0.5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	—	mA
	2.5	0.5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	—	
	9.5	0.10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	—	
	13.5	0.15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	—	
Output Voltage: Low-Level, V _{OL} Max.	—	0.5	5	0.05			—	0	0.05	V	
	—	0.10	10	0.05			—	0	0.05		
	—	0.15	15	0.05			—	0	0.05		
Output Voltage: High-Level, V _{OH} Min.	—	0.5	5	4.95			4.95	5	—	V	
	—	0.10	10	9.95			9.95	10	—		
	—	0.15	15	14.95			14.95	15	—		
Input Low Voltage, V _{IL} Max.	0.5, 4.5	—	5	1.5			—	—	1.5	V	
	1, 9	—	10	3			—	—	3		
	1.5, 13.5	—	15	4			—	—	4		
	0.5, 4.5	—	5	3.5			3.5	—	—		
Input High Voltage, V _{IH} Min.	1, 9	—	10	7			7	—	—	V	
	1.5, 13.5	—	15	11			11	—	—		
Input Current I _{IN} Max.	—	0.18	18	± 0.1	± 0.1	± 1	± 1	—	$\pm 10^{-5}$	± 0.1	μ A

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RECOMMENDED OPERATING CONDITIONS at $T_A = 25^\circ\text{C}$, Except as Noted.
 For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIMITS		UNITS
	MIN.	MAX.	
Supply-Voltage Range (For $T_A = \text{Full Package Temperature Range}$)	3	18	V

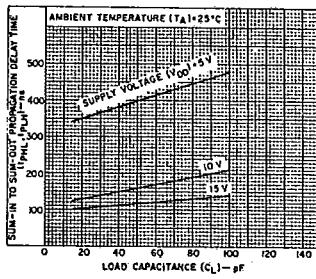


Fig.3 — Typical sum-in to sum-out propagation delay time vs. load capacitance.

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (V_{DD})Voltages referenced to V_{SS} Terminal) -0.5V to +20V

INPUT VOLTAGE RANGE, ALL INPUTS

..... -0.5V to V_{DD} +0.5V

DC INPUT CURRENT, ANY ONE INPUT

..... $\pm 10\text{mA}$ POWER DISSIPATION PER PACKAGE (P_D):For $T_A = -55^\circ\text{C}$ to $+100^\circ\text{C}$ 500mWFor $T_A = +100^\circ\text{C}$ to $+125^\circ\text{C}$ Derate Linearly at 12mW/ $^\circ\text{C}$ to 200mW

DEVICE DISSIPATION PER OUTPUT TRANSISTOR

FOR $T_A = \text{FULL PACKAGE-TEMPERATURE RANGE}$ (All Package Types) 100mWOPERATING-TEMPERATURE RANGE (T_A) -55 $^\circ\text{C}$ to +125 $^\circ\text{C}$ STORAGE TEMPERATURE RANGE (T_{STG}) -65 $^\circ\text{C}$ to +150 $^\circ\text{C}$

LEAD TEMPERATURE (DURING SOLDERING):

At distance $1/16 \pm 1/32$ inch ($1.59 \pm 0.79\text{mm}$) from case for 10s max +265 $^\circ\text{C}$

3A

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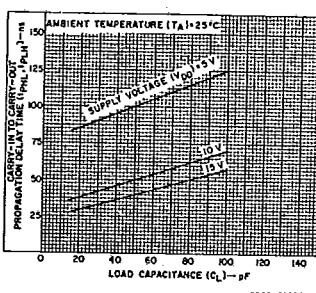


Fig.4 — Typical carry-in to carry-out propagation delay time vs. load capacitance.

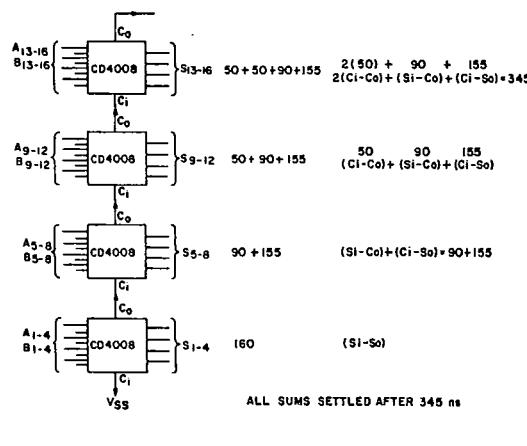


Fig.2 — Typical propagation delay for a 16-bit adder (10 V operation).

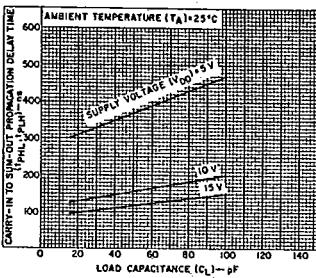


Fig.5 — Typical carry-in to sum-out propagation delay time vs. load capacitance.

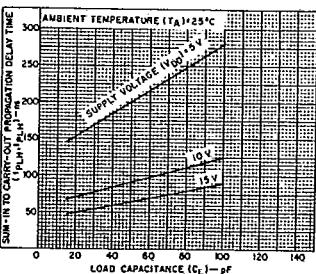


Fig.6 — Typical sum-in to carry-out propagation delay time vs. load capacitance.

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DYNAMIC ELECTRICAL CHARACTERISTICS
At $T_A = 25^\circ\text{C}$, Input $t_r, t_f = 20\text{ ns}$, $C_L = 50\text{ pF}$, $R_L = 200\text{k}\Omega$

CHARACTERISTIC	V _{DD} (V)	LIMITS		UNITS
		TYP.	MAX.	
Propagation Delay Time: t _{PHL} , t _{PLH}	5	400	800	ns
	10	160	320	
	15	115	230	
Sum In to Sum Out	5	370	740	ns
	10	155	310	
	15	115	230	
Carry In to Sum Out	5	370	740	ns
	10	155	310	
	15	115	230	
Sum In to Carry Out	5	200	400	ns
	10	90	180	
	15	65	130	
Carry In to Carry Out	5	100	200	ns
	10	50	100	
	15	40	80	
Transition Time: t _{THL} , t _{TLH}	5	100	200	ns
	10	50	100	
	15	40	80	
Input Capacitance, C _{IN}	-	5	7.5	pF

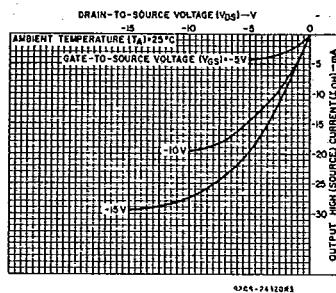


Fig.7 — Typical output high (source)
current characteristics.

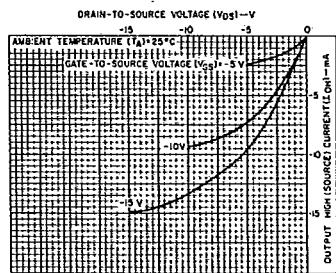


Fig.8 — Minimum output high (source)
current characteristics.

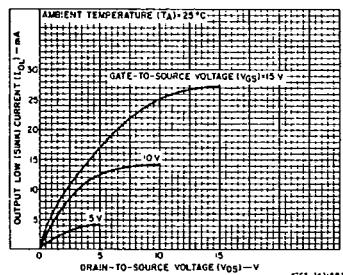


Fig.9 — Typical output low (sink)
current characteristics.

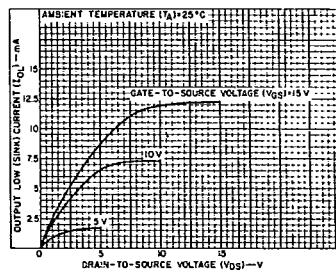


Fig.10 — Minimum output low (sink)
current characteristics.

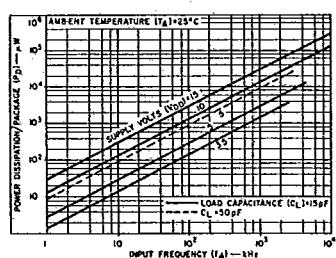


Fig.11 — Typical dissipation characteristics.

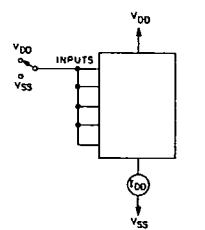


Fig.12 — Quiescent-device-current test circuit.

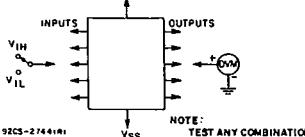


Fig.13 — Input-voltage test circuit.

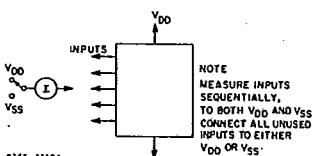
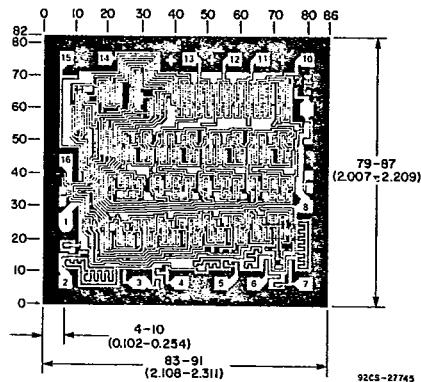


Fig.14 — Input current test circuit.

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Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10^{-3} inch).

Dimensions and Pad Layout for CD4008BH

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